

## **IEC QUALITY ASSESSMENT SYSTEM (IECQ)**

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

## Schedule of Scope to Certificate of Approval

## **Independent Testing Laboratory**

IECQ Certificate No.: IECQ-L DEKRA 16.0002-04

CB Certificate No.: DEKRA-T5E-003

Schedule Number: IECQ-L DEKRA 16.0002-04-S Rev No.: 1 Revision Date: 2025/08/14 Page 1 of 1

## Environmental and Reliability Testing of Electronic Components, Assemblies, and Related Materials

| Description test       | Standard                     |
|------------------------|------------------------------|
| TEM analysis           | A00-530-30057, A00-530-30197 |
| DUAL BEAM FIB analysis | A00-530-30130                |

This schedule is only valid in conjunction with the referenced Certificate of Approval
This approval and any schedule(s) may only be reproduced in full.
This approval is not transferable and remains the property of the issuing body.
The Status and authenticity of this approval and any schedule(s) may be verified by visiting the
Official IECQ Website. <a href="www.iecq.org">www.iecq.org</a>

